OptiMOS®-T Power-Transistor

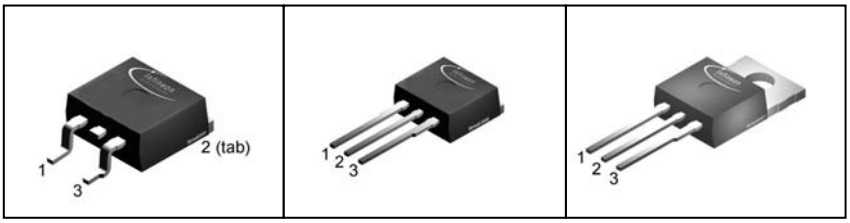
Features

- N-channel - Enhancement mode
- Automotive AEC Q101 qualified
- MSL1 up to 260°C peak reflow
- 175°C operating temperature
- Green package (lead free)
- Ultra low Rds(on)
- Avalanche tested
- ESD Class 2 (HBM)
  EIA/JESD22-A114-B

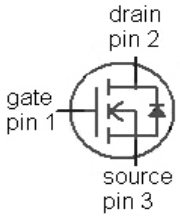
Product Summary

V_{DS}	55	V
$R_{DS(on),max}$ (SMD version)	8.8	mΩ
I_D	77	A

PG-TO263-3-2 PG-TO262-3-1 PG-TO220-3-1



Type	Package	Ordering Code	Marking
IPB77N06S3-09	PG-TO263-3-2	SP0000-88715	3N0609
IPI77N06S3-09	PG-TO262-3-1	SP0000-88716	3N0609
IPP77N06S3-09	PG-TO220-3-1	SP0000-88717	3N0609



Maximum ratings, at T_j=25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current[1]	I_D	T_C=25 °C, V_{GS}=10 V	77	A
		T_C=100 °C, V_{GS}=10 V[2]	55	
Pulsed drain current[2]	$I_{D,pulse}$	T_C=25 °C	308	
Avalanche energy, single pulse[3]	E_{AS}	I_D=38 A	170	mJ
Drain gate voltage[2]	V_{DG}		55	
Gate source voltage[4]	V_{GS}		±20	V
Power dissipation	P_{tot}	T_C=25 °C	107	W
Operating and storage temperature	T_j, T_{stg}		-55 ... +175	°C
IEC climatic category; DIN IEC 68-1			55/175/56	

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Thermal characteristics[2]						
Thermal resistance, junction - case	R_{thJC}		-	-	1.4	K/W
Thermal resistance, junction - ambient, leaded	R_{thJA}		-	-	62	
SMD version, device on PCB	R_{thJA}	minimal footprint	-	-	62	
		6 cm^2 cooling area[5]	-	-	40	
Electrical characteristics, at T_j=25 °C, unless otherwise specified						
Static characteristics						
Drain-source breakdown voltage	$V_{(BR)DSS}$	V_{GS}=0 V, I_D=250 µA	55	-	-	V
Gate threshold voltage	$V_{GS(th)}$	V_{DS}=V_{GS}, I_D=55 µA	2.1	3	4	
Zero gate voltage drain current	I_{DSS}	V_{DS}=25 V, V_{GS}=0 V, T_j=25 °C	-	0.1	1	µA
		V_{DS}=25 V, V_{GS}=0 V, T_j=125 °C[1]	-	1	100	
Gate-source leakage current	I_{GSS}	V_{GS}=20 V, V_{DS}=0 V	-	1	100	nA
Drain-source on-state resistance	$R_{DS(on)}$	V_{GS}=10 V, I_D=39 A	-	7.7	9.1	mΩ
		V_{GS}=10 V, I_D=39 A, SMD version	-	7.4	8.8	

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Dynamic characteristics[2]						
Input capacitance	C_{iss}	V_{GS}=0 V, V_{DS}=25 V, f=1 MHz	-	5335	-	pF
Output capacitance	C_{oss}		-	812	-	
Reverse transfer capacitance	C_{rss}		-	775	-	
Turn-on delay time	$t_{d(on)}$	V_{DD}=27.5 V, V_{GS}=10 V, I_D=77 A, R_G=10 Ω	-	29	-	ns
Rise time	t_r		-	51	-	
Turn-off delay time	$t_{d(off)}$		-	29	-	
Fall time	t_f		-	51	-	
Gate Charge Characteristics[2]						
Gate to source charge	Q_{gs}	V_{DD}=11 V, I_D=77 A, V_{GS}=0 to 10 V	-	41	-	nC
Gate to drain charge	Q_{gd}		-	17	-	
Gate charge total	Q_g		-	77	103	
Gate plateau voltage	$V_{plateau}$		-	7.1	-	V
Reverse Diode						
Diode continous forward current	I_S	T_C=25 °C	-	-	77	A
Diode pulse current[2]	$I_{S,pulse}$		-	-	308	
Diode forward voltage[2]	V_{SD}	V_{GS}=0 V, I_F=77 A, T_j=25 °C	-	1	1.3	V
Reverse recovery time[2]	t_{rr}	V_R=27.5 V, I_F=I_S, di_F/dt=100 A/µs	-	43	-	ns
Reverse recovery charge[2]	Q_{rr}		-	58	-	nC

[1] Current is limited by bondwire; with an R_{thJC} = 1.4 K/W the chip is able to carry 77A at 25°C. For detailed information see Application Note ANPS071E at *www.infineon.com/optimos*

[2] Defined by design. Not subject to production test.

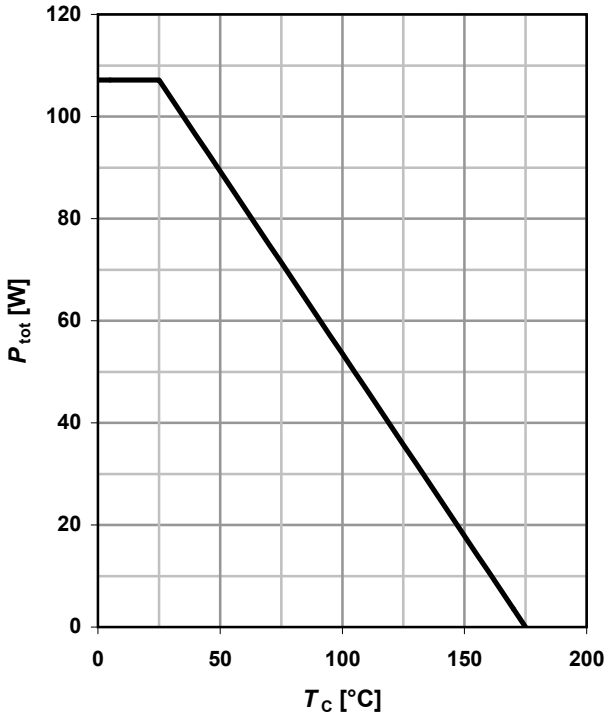
[3] See diagrams 12 and 13.

[4] Qualified at -5V and +20V.

[5] Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm^2 (one layer, 70 µm thick) copper area for drain connection. PCB is vertical in still air.

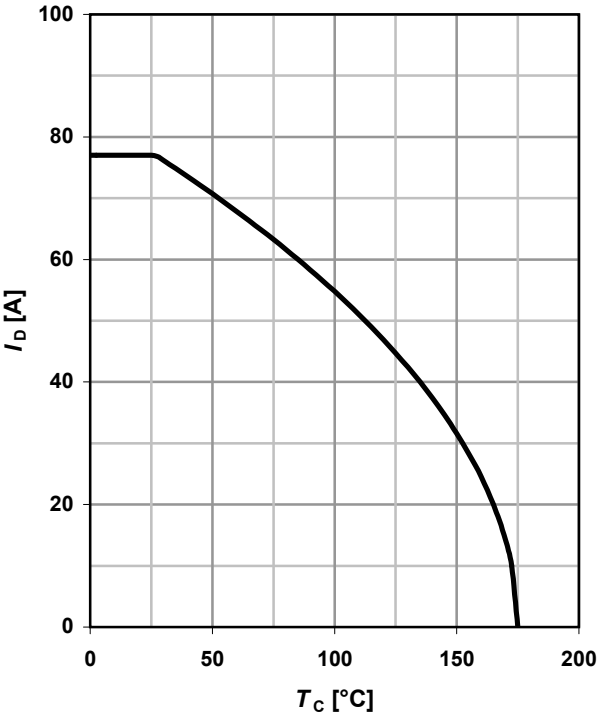
1 Power dissipation

$P_{tot}=f(T_C)$; $V_{GS}\geq 6$ V



2 Drain current

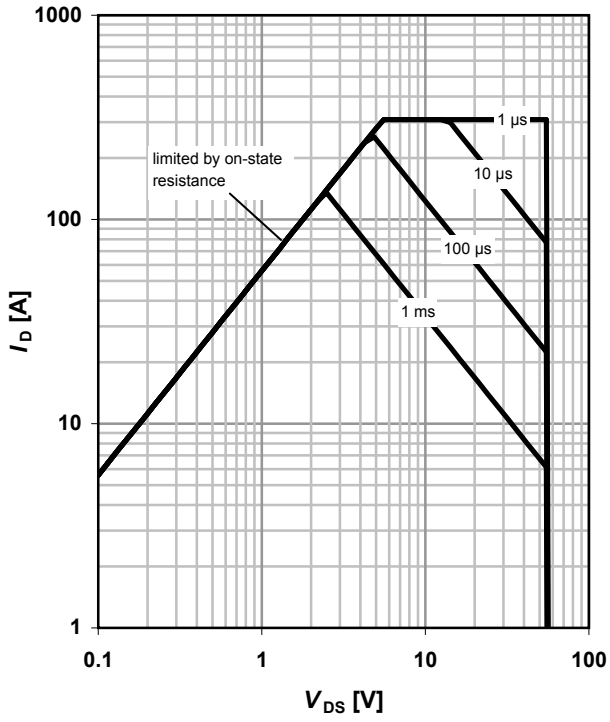
$I_D=f(T_C)$; $V_{GS}\geq 10$ V



3 Safe operating area

$I_D=f(V_{DS})$; $T_C=25$ °C; $D=0$

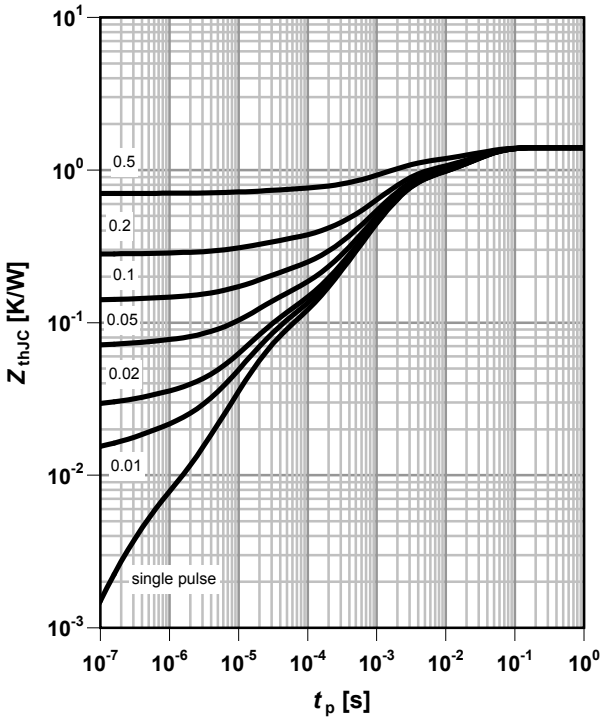
parameter: t_p



4 Max. transient thermal impedance

$Z_{thJC}=f(t_p)$

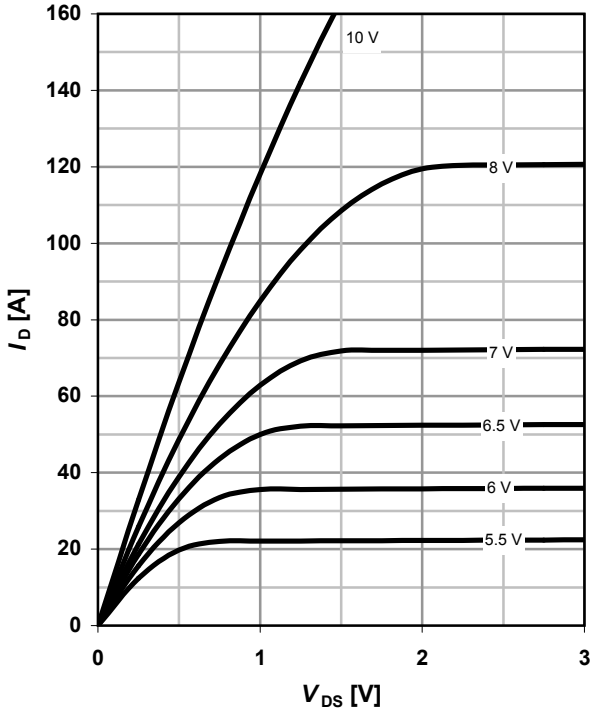
parameter: $D=t_p/T$



5 Typ. output characteristics

I_D=f(V_{DS}); T_j=25 °C

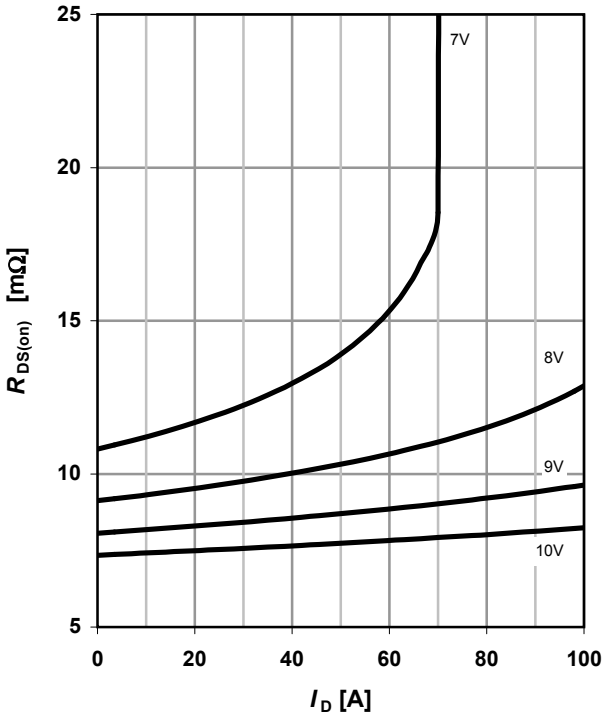
parameter: V_{GS}, pulsed



6 Typ. drain-source on resistance

$R_{DS(on)}$=f(I_D); T_j=25 °C

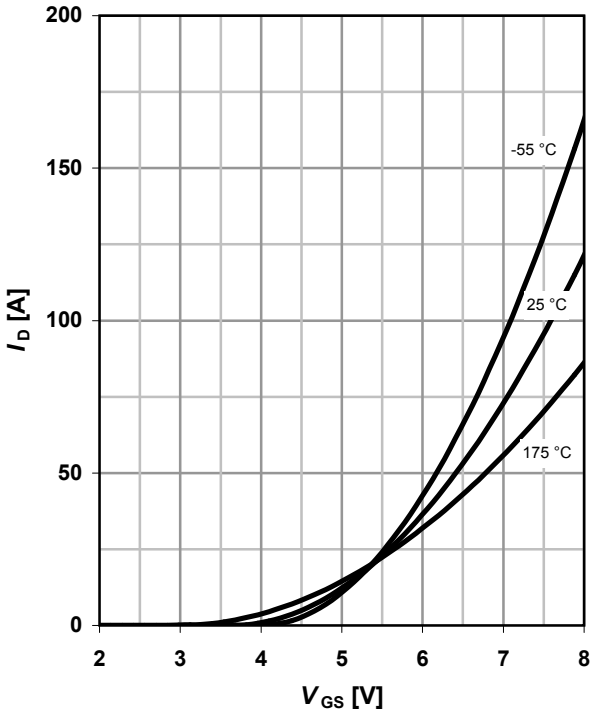
parameter: V_{GS}



7 Typ. transfer characteristics

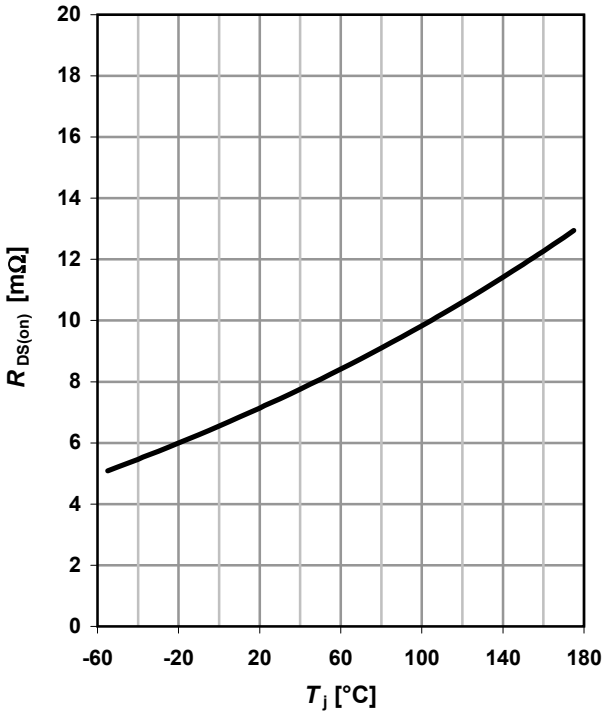
I_D=f(V_{GS}); V_{DS}=10 V

parameter: T_j



8 Drain-source on-state resistance

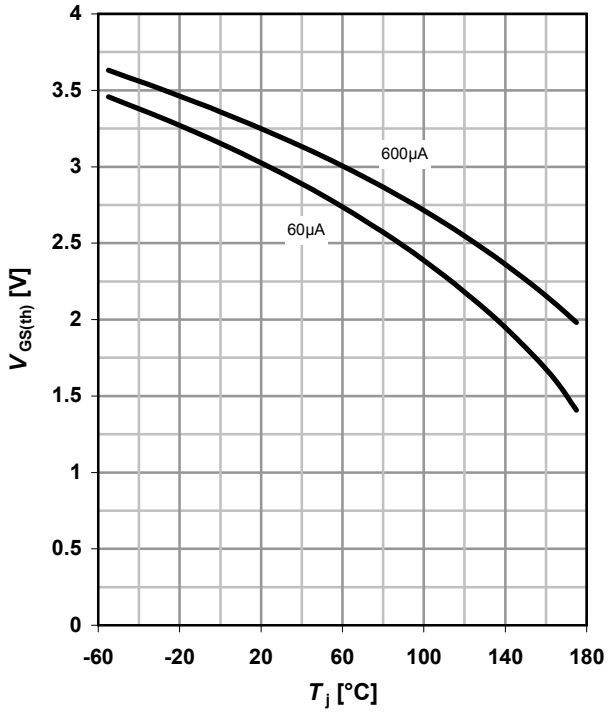
$R_{DS(on)}$=f(T_j); I_D=77 A; V_{GS}=10 V



9 Typ. gate threshold voltage

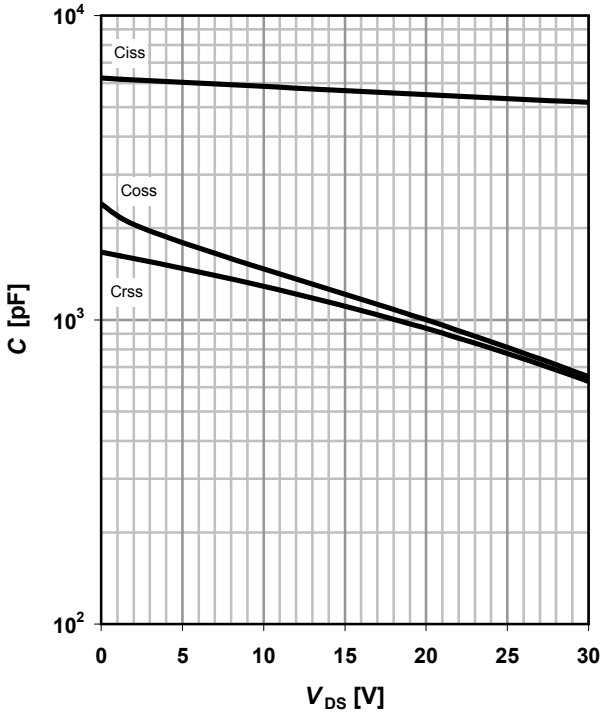
$V_{GS(th)}=f(T_j)$; $V_{GS}=V_{DS}$

parameter: I_D



10 Typ. capacitances

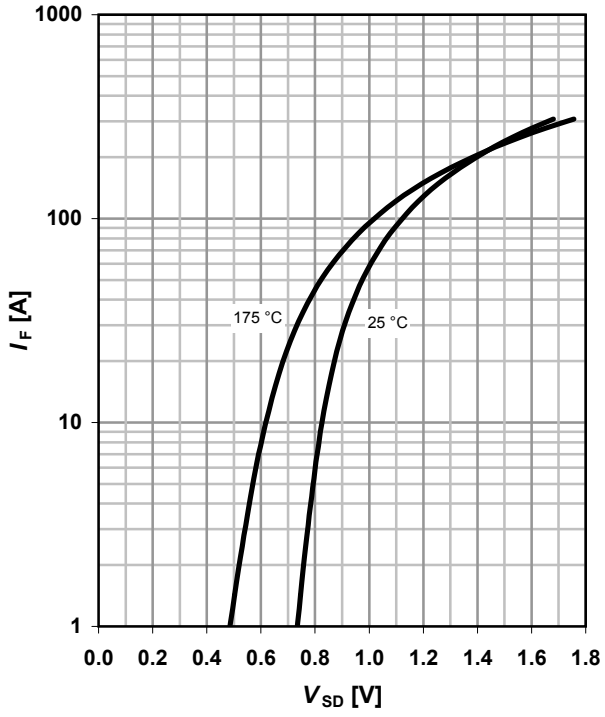
$C=f(V_{DS})$; $V_{GS}=0$ V; $f=1$ MHz



11 Forward characteristics of reverse diode

$I_F=f(V_{SD})$, pulsed

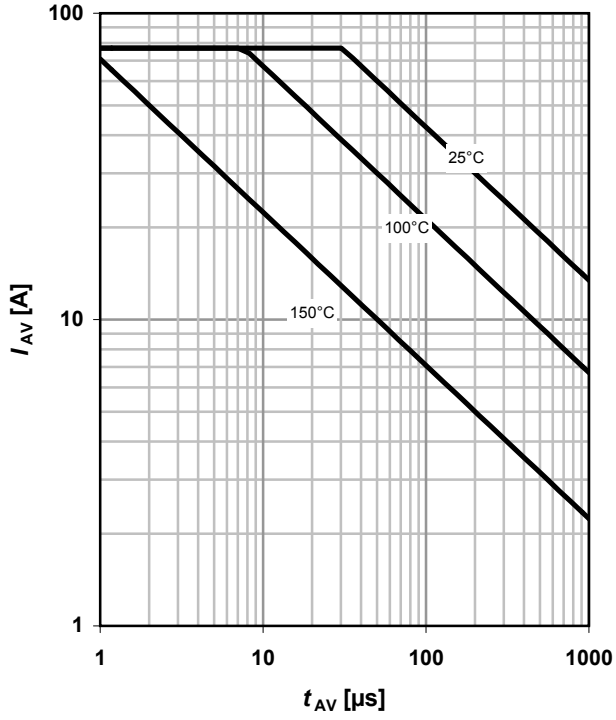
parameter: T_j



12 Typ. avalanche characteristics

$I_{AS}=f(t_{AV})$

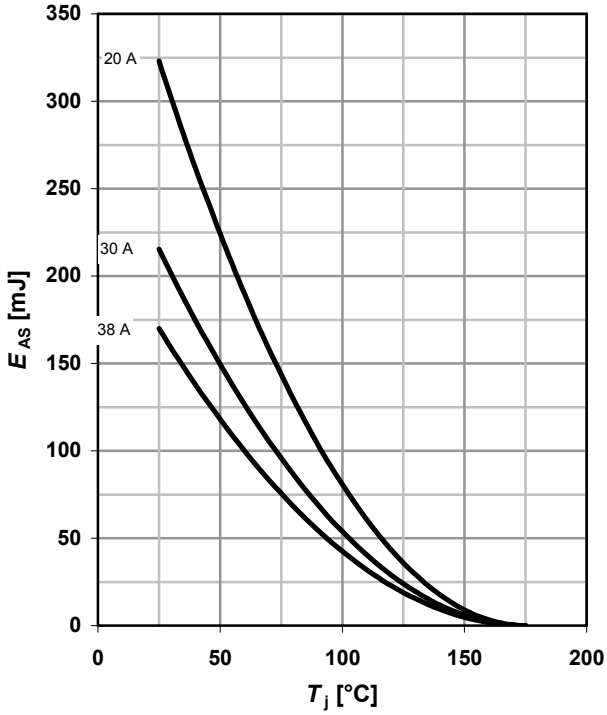
parameter: $T_{j(start)}$



13 Typ. avalanche energy

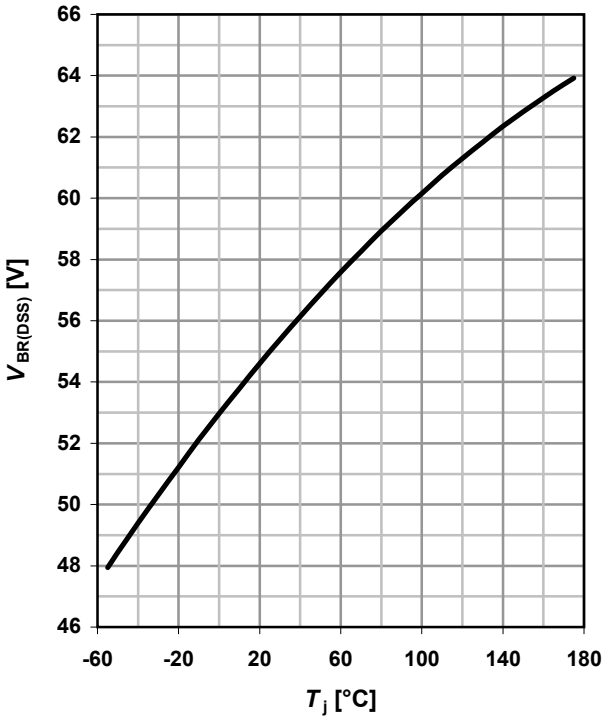
$E_{AS}=f(T_j)$

parameter: I_D



15 Drain-source breakdown voltage

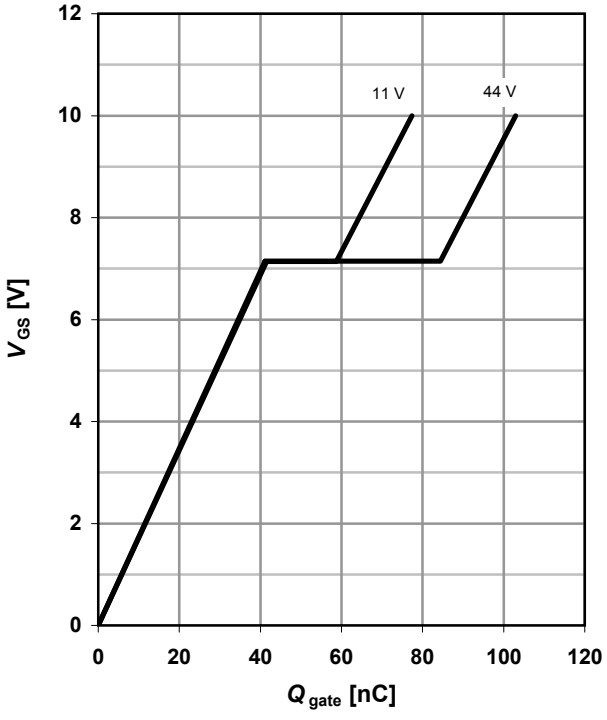
$V_{BR(DSS)}=f(T_j)$; I_D=1 mA



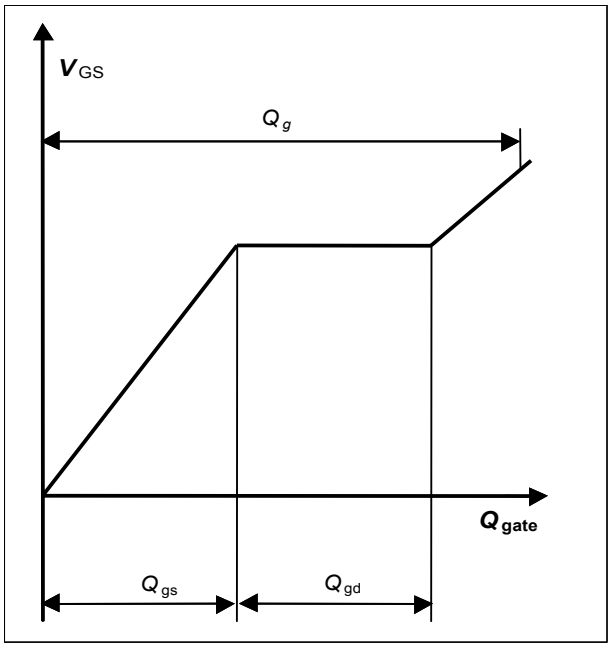
14 Typ. gate charge

$V_{GS}=f(Q_{gate})$; I_D=77 A pulsed

parameter: V_{DD}



16 Gate charge waveforms



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